





# **Complementary Enhancement Mode Field Effect Transistor**

# **General Description**

The AOD604 uses advanced trench technology MOSFETs to provide excellent  $R_{DS(ON)}$  and low gate charge. The complementary MOSFETs may be used in H-bridge, Inverters and other applications. Standard product AOD604 is Pbfree (meets ROHS & Sony 259 specifications). AOD604L is a Green Product ordering option. AOD604 and AOD604L are electrically identical.

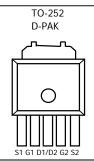
## **Features**

n-channel p-channel  $V_{DS}(V) = 40V$  -40V

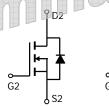
 $I_D = 8A (V_{GS} = 10V)$  -8A  $(V_{GS} = -10V)$ 

 $R_{DS(ON)} \hspace{1cm} R_{DS(ON)}$ 

 $< 33 \text{ m}\Omega \text{ (V}_{GS}=10\text{V)}$   $< 50 \text{ m}\Omega \text{ (V}_{GS}=-10\text{V)}$   $< 47 \text{ m}\Omega \text{ (V}_{GS}=4.5\text{V)}$   $< 75 \text{ m}\Omega \text{ (V}_{GS}=-4.5\text{V)}$ 



Top View Drain Connected to Tab







p-channel

Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Parameter		Symbol	Max n-channel	Max p-channel	Units	
Drain-Source Voltage		$V_{DS}$	40	-40	V	
Gate-Source Voltage		$V_{GS}$	±20	±20	V	
Continuous Drain	T <sub>C</sub> =25°C		8	8 8		
Current <sup>G</sup>	T <sub>C</sub> =100°C	$I_D$	8	8	Α	
Pulsed Drain Current C		I <sub>DM</sub>	30	-30		
Avalanche Current <sup>C</sup>		I <sub>AR</sub>	8	-8	Α	
Repetitive avalanche energy L=0.1mH <sup>C</sup>		E <sub>AR</sub>	20	30	mJ	
	T <sub>C</sub> =25°C	$P_{D}$	20	50	W	
Power Dissipation <sup>B</sup>	T <sub>C</sub> =100°C	7' 0	10	25	VV	
	T <sub>A</sub> =25°C	P <sub>DSM</sub>	2	2.5	W	
Power Dissipation <sup>A</sup>	T <sub>A</sub> =70°C	] DSM	1.3	1.6	VV	
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 175	-55 to 175	°C	

Thermal Characteristics: n-channel and p-channel

Parameter	Symbol	Device	Тур	Max		
Maximum Junction-to-Ambient <sup>A</sup> t ≤ 10s		$R_{\scriptscriptstyle{ hetaJA}}$	n-ch	17.4	30	°C/W
Maximum Junction-to-Ambient A	Steady-State	Γ <sub>θ</sub> JA	n-ch	50	60	°C/W
Maximum Junction-to-Case <sup>B</sup> Steady-State		$R_{\theta JC}$	n-ch	4	7.5	°C/W
Maximum Junction-to-Ambient <sup>A</sup>	t ≤ 10s	t ≤ 10s		16.7	25	°C/W
Maximum Junction-to-Ambient A	Steady-State	КθЈА	p-ch	40	50	°C/W
Maximum Junction-to-Case <sup>B</sup>	Steady-State	$R_{\theta JC}$	p-ch	2.5	4	°C/W

### N-Channel MOSFET Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units		
STATIC F	PARAMETERS								
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =10mA, V <sub>GS</sub> =0V		40			V		
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS}$ =32V, $V_{GS}$ =0V				1	μА		
-500		T <sub>J</sub> =55				5	μΑ		
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ =±20V				100	nA		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$		1	2.3	3	V		
$I_{D(ON)}$	On state drain current	$V_{GS}$ =10V, $V_{DS}$ =5V		30			Α		
		$V_{GS}$ =10V, $I_D$ =8A			25	33	3 mΩ		
$R_{DS(ON)}$	Static Drain-Source On-Resistance		T <sub>J</sub> =125°C		39	52	11122		
		$V_{GS}$ =4.5V, $I_D$ =6A			34	47	mΩ		
g <sub>FS</sub>	Forward Transconductance	$V_{DS}$ =5V, $I_D$ =8A			25		S		
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A, V <sub>GS</sub> =0V			0.76	1	V		
Is	Maximum Body-Diode Continuous Curr	de Continuous Current				8	Α		
DYNAMIC	PARAMETERS								
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =20V, f=1MHz V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz			404		pF		
C <sub>oss</sub>	Output Capacitance				95		pF		
C <sub>rss</sub>	Reverse Transfer Capacitance				37		pF		
$R_g$	Gate resistance				2.7		Ω		
SWITCHI	NG PARAMETERS								
Q <sub>g</sub> (10V)	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =20V, I <sub>D</sub> =8A			9.2		nC		
Q <sub>g</sub> (4.5V)	Total Gate Charge				4.5		nC		
$Q_{gs}$	Gate Source Charge				1.6		nC		
$Q_{gd}$	Gate Drain Charge				2.6		nC		
t <sub>D(on)</sub>	Turn-On DelayTime				3.5		ns		
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =20V, $R_L$ =2.5 $\Omega$ , $R_{GEN}$ =3 $\Omega$			6		ns		
$t_{D(off)}$	Turn-Off DelayTime				13.2		ns		
t <sub>f</sub>	Turn-Off Fall Time				3.5		ns		
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =8A, dI/dt=100A/μs			22.9		ns		
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	l <sub>F</sub> =8A, dl/dt=100A/μs			18.3		nC		

A: The value of R  $_{0JA}$  is measured with the device mounted on 1 in  $^2$  FR-4 board with 2oz. Copper, in a still air environment with T  $_A$  =25°C. The Power dissipation P $_{DSM}$  is based on R  $_{0JA}$  and the maximum allowed junction temperature of 150°C. The value in any a given application depends on the user's specific board design, and the maximum temperature fo 175°C may be used if the PCB allows it.

- B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- C: Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}=175$ °C.
- D. The R  $_{\theta JA}$  is the sum of the thermal impedence from junction to case R  $_{\theta JC}$  and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using  $<300~\mu s$  pulses, duty cycle 0.5% max.
- F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}$ =175°C.
- G. The maximum current rating is limited by bond-wires.
- H. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The SOA curve provides a single pulse rating.

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### P-Channel MOSFET Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC F	PARAMETERS			•	•	•
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-40			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =-32V, V <sub>GS</sub> =0V			-1	μА
יטאי		T <sub>J</sub> =55°C			-5	μΛ
I <sub>GSS</sub>	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ =±20V			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_D=-250\mu A$	-1	-1.8	-3	V
$I_{D(ON)}$	On state drain current	V <sub>GS</sub> =-10V, V <sub>DS</sub> =-5V	-30			Α
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =-10V, I <sub>D</sub> =-8A		41	50	mΩ
		T <sub>J</sub> =125°C		62		11152
		$V_{GS}$ =-4.5V, $I_D$ =-6A		60	75	mΩ
g <sub>FS</sub>	Forward Transconductance	$V_{DS}$ =-5V, $I_{D}$ =-8A		16		S
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =-1A,V <sub>GS</sub> =0V		-0.75	-1	V
Is	Maximum Body-Diode Continuous Current				-8	Α
DYNAMIC	CPARAMETERS					
C <sub>iss</sub>	Input Capacitance			657		pF
Coss	Output Capacitance	$V_{GS}$ =0V, $V_{DS}$ =-20V, f=1MHz		143		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			63		pF
$R_g$	Gate resistance	$V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz		6.5		Ω
SWITCHI	NG PARAMETERS					
Q <sub>g</sub> (10V)	Total Gate Charge (10V)			14.1		nC
Q <sub>g</sub> (4.5V)	Total Gate Charge (4.5V)	V <sub>GS</sub> =-10V, V <sub>DS</sub> =-20V, I <sub>D</sub> =-8A		7		nC
$Q_{gs}$	Gate Source Charge	V <sub>GS</sub> =-10V, V <sub>DS</sub> =-20V, I <sub>D</sub> =-0A		2.2		nC
$Q_{gd}$	Gate Drain Charge			4.1		nC
t <sub>D(on)</sub>	Turn-On DelayTime			8		ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =-10V, $V_{DS}$ =-20V, $R_L$ =2.5 $\Omega$ ,		12.2		ns
t <sub>D(off)</sub>	Turn-Off DelayTime	$R_{GEN}=3\Omega$		24		ns
t <sub>f</sub>	Turn-Off Fall Time	]		12.5		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =-8A, dI/dt=100A/μs		23.2		ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =-8A, dI/dt=100A/μs		18.2		nC

A: The value of R qJA is measured with the device mounted on 1 in 2 FR-4 board with 2 oz. Copper, in a still air environment with T A =25°C. The Power dissipation PDSM is based on R qJA and the maximum allowed junction temperature of 150°C. The value in any a given application depends on the user's specific board design, and the maximum temperature fo 175°C may be used if the PCB allows it.

- C: Repetitive rating, pulse width limited by junction temperature TJ(MAX)=175°C.
- D. The R qJA is the sum of the thermal impedence from junction to case R qJC and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300 ms pulses, duty cycle 0.5% max.
- F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of TJ(MAX)=175°C.
- G. The maximum current rating is limited by bond-wires.
- H. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with TA=25°C. The SOA curve provides a single pulse rating.

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B. The power dissipation PD is based on  $\overline{\text{TJ}}(\text{MAX})=175^{\circ}\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.